74LVC595A

8-bit serial-in/serial-out or parallel-out shift register; 3-state

Rev. 3 — 19 November 2021 Product data sheet

1. General description

The 74LVC595A is an 8-bit serial-in/serial or parallel-out shift register with a storage register and 3-state outputs. Both the shift and storage register have separate clocks. The device features a serial input (DS) and a serial output (Q7S) to enable cascading and an asynchronous reset $\overline{\text{MR}}$ input. A LOW on $\overline{\text{MR}}$ will reset the shift register. Data is shifted on the LOW-to-HIGH transitions of the SHCP input. The data in the shift register is transferred to the storage register on a LOW-to-HIGH transition of the STCP input. If both clocks are connected together, the shift register will always be one clock pulse ahead of the storage register. Data in the storage register appears at the output whenever the output enable input ($\overline{\text{OE}}$) is LOW. A HIGH on $\overline{\text{OE}}$ causes the outputs to assume a high-impedance OFF-state. Operation of the $\overline{\text{OE}}$ input does not affect the state of the registers. Inputs can be driven from either 3.3 V or 5 V devices. This feature allows the use of these devices as translators in mixed 3.3 V and 5 V environments. Schmitt-trigger action at all inputs makes the circuit tolerant of slower input rise and fall times. This device is fully specified for partial power down applications using I_{OFF} . The I_{OFF} circuitry disables the output, preventing the potentially damaging backflow current through the device when it is powered down.

2. Features and benefits

- Wide supply voltage range from 1.2 V to 3.6 V
- Overvoltage tolerant inputs to 5.5 V
- · CMOS low power dissipation
- Direct interface with TTL levels
- I_{OFF} circuitry provides partial Power-down mode operation
- · Balanced propagation delays
- All inputs have Schmitt-trigger action
- Complies with JEDEC standard:
 - JESD8-7A (1.65 V to 1.95 V)
 - JESD8-5A (2.3 V to 2.7 V)
 - JESD8-C/JESD36 (2.7 V to 3.6 V)
- ESD protection:
 - HBM JESD22-A114F exceeds 2000 V
 - MM JESD22-A115-B exceeds 200 V
 - CDM JESD22-C101E exceeds 1000 V
- Specified from -40 °C to +85 °C and -40 °C to +125 °C

3. Applications

- Serial-to-parallel data conversion
- Remote control holding register



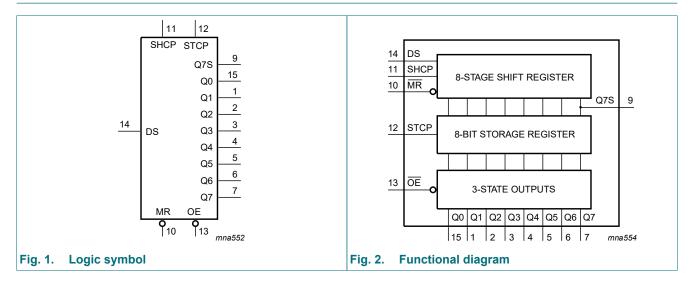
8-bit serial-in/serial-out or parallel-out shift register; 3-state

4. Ordering information

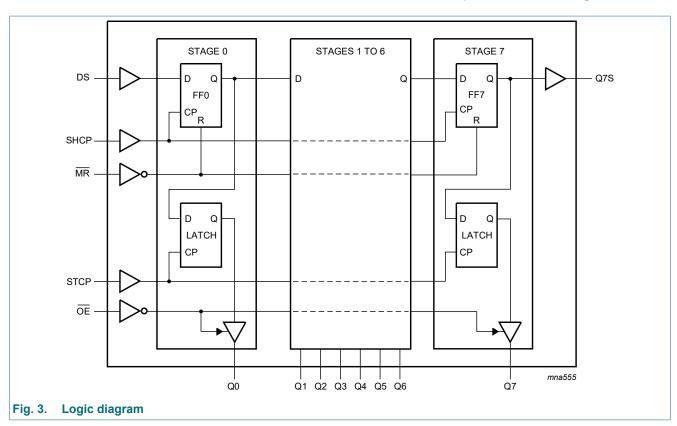
Table 1. Ordering information

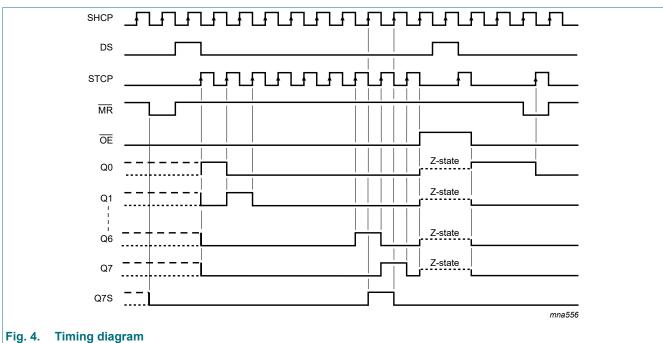
Type number	Package	Package								
	Temperature range	Name	Description	Version						
74LVC595AD	-40 °C to +125 °C	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1						
74LVC595APW	-40 °C to +125 °C	TSSOP16	plastic thin shrink small outline package; 16 leads; body width 4.4 mm	SOT403-1						
74LVC595ABQ	-40 °C to +125 °C	DHVQFN16	plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body 2.5 × 3.5 × 0.85 mm	SOT763-1						

5. Functional diagram



8-bit serial-in/serial-out or parallel-out shift register; 3-state

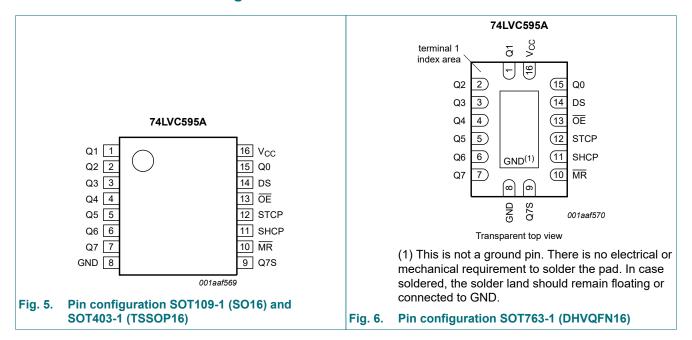




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6. Pinning information

6.1. Pinning



6.2. Pin description

Table 2. Pin description

Symbol	Pin	Description
Q0, Q1, Q2, Q3, Q4, Q5, Q6, Q7	15, 1, 2, 3, 4, 5, 6, 7	parallel data output
GND	8	ground (0 V)
Q7S	9	serial data output
MR	10	master reset (active LOW)
SHCP	11	shift register clock input
STCP	12	storage register clock input
ŌĒ	13	output enable input (active LOW)
DS	14	serial data input
V _{CC}	16	supply voltage

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7. Functional description

Table 3. Function table

 $H = HIGH \ voltage \ state; \ L = LOW \ voltage \ state; \ \uparrow = LOW-to-HIGH \ transition; \ X = don't \ care; \ NC = no \ change; \ Z = high-impedance \ OFF-state.$

Input					Outpu	t	Function
SHCP	STCP	OE	MR	DS	Q7S	Qn	
Χ	Х	L	L	Х	L	NC	a LOW-state on MR only affects the shift register
Χ	1	L	L	Х	L	L	empty shift register loaded into storage register
Χ	Х	Н	L	Х	L	Z	shift register clear; parallel outputs in high impedance OFF-state
↑	Х	L	Н	Н	Q6S	NC	logic HIGH-state shifted into shift register stage 0. Contents of all shift register stages shifted through, e.g. previous state of stage 6 (internal Q6S) appears on the serial output (Q7S).
X	1	L	Н	Х	NC	QnS	contents of shift register stages (internal QnS) are transferred to the storage register and parallel output stages
↑	1	L	Н	X	Q6S	QnS	contents of shift register shifted through; previous contents of the shift register is transferred to the storage register and the parallel output stages

8. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC}	supply voltage			-0.5	+6.5	V
I _{IK}	input clamping current	V _I < 0 V		-50	-	mA
VI	input voltage		[1]	-0.5	+6.5	V
I _{OK}	output clamping current	$V_O > V_{CC}$ or $V_O < 0$ V		-	±50	mA
Vo	output voltage	3-state	[1]	-0.5	6.5	V
		output HIGH or LOW state	[1]	-0.5	V _{CC} + 0.5	V
Io	output current	$V_O = 0 \text{ V to } V_{CC}$		-	±50	mA
I _{CC}	supply current			-	100	mA
I _{GND}	ground current			-100	-	mA
T _{stg}	storage temperature			-65	+150	°C
P _{tot}	total power dissipation	T _{amb} = -40 °C to +125 °C	[2]	-	500	mW

^[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

^[2] For SOT109-1 (SO16) package: Ptot derates linearly with 12.4 mW/K above 110 °C.

For SOT403-1 (TSSOP16) package: Ptot derates linearly with 8.5 mW/K above 91 °C.

For SOT763-1 (DHVQFN16) package: Ptot derates linearly with 11.2 mW/K above 106 °C.

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9. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage		1.65	-	3.6	V
		functional	1.2	-	-	V
VI	input voltage		0	-	5.5	V
Vo	output voltage	3-state	0	-	5.5	V
		output HIGH or LOW state	0	-	V _{CC}	V
T _{amb}	ambient temperature		-40	-	+125	°C
Δt/ΔV	input transition rise and fall rate	V _{CC} = 1.65 V to 2.7 V	0	-	20	ns/V
		V _{CC} = 2.7 V to 3.6 V	0	-	10	ns/V

10. Static characteristics

Table 6. Static characteristics

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	-40	°C to +8	5 °C	-40 °C to	+125 °C	Unit
			Min	Typ[1]	Max	Min	Max	
V _{IH}	HIGH-level	V _{CC} = 1.2 V	1.08	-	-	1.08	-	V
	input voltage	V _{CC} = 1.65 V to 1.95 V	0.65 × V _{CC}	-	-	0.65 × V _{CC}	-	V
		V _{CC} = 2.3 V to 2.7 V	1.7	-	-	1.7	-	V
		V _{CC} = 2.7 V to 3.6 V	2.0	-	-	2.0	-	V
V _{IL}	LOW-level	V _{CC} = 1.2 V	-	-	0.12	-	0.12	V
input voltage	V _{CC} = 1.65 V to 1.95 V	-	-	0.35 × V _{CC}	-	0.35 × V _{CC}	V	
		V _{CC} = 2.3 V to 2.7 V	-	-	0.7	-	0.7	V
		V _{CC} = 2.7 V to 3.6 V	-	-	0.8	-	0.8	V
U	HIGH-level output voltage	V _I = V _{IH} or V _{IL}						
		I _O = -100 μA; V _{CC} = 1.65 V to 3.6 V	V _{CC} - 0.2	-	-	V _{CC} - 0.3	-	V
		I _O = -4 mA; V _{CC} = 1.65 V	1.2	-	-	1.05	-	V
		I _O = -8 mA; V _{CC} = 2.3 V	1.8	-	-	1.65	-	V
		I _O = -12 mA; V _{CC} = 2.7 V	2.2	-	-	2.05	-	V
		I _O = -18 mA; V _{CC} = 3.0 V	2.4	-	-	2.25	-	V
		I _O = -24 mA; V _{CC} = 3.0 V	2.2	-	-	2.0	-	V
V _{OL}	LOW-level	V _I = V _{IH} or V _{IL}						
	output voltage	I _O = 100 μA; V _{CC} = 1.65 V to 3.6 V	-	-	0.2	-	0.3	V
		I _O = 4 mA; V _{CC} = 1.65 V	-	-	0.45	-	0.65	V
		I _O = 8 mA; V _{CC} = 2.3 V	-	-	0.6	-	0.8	V
		I _O = 12 mA; V _{CC} = 2.7 V	-	-	0.4	-	0.6	V
		I _O = 24 mA; V _{CC} = 3.0 V	-	-	0.55	-	0.8	V
l _l	input leakage current	V _{CC} = 3.6 V; V _I = 5.5 V or GND	-	±0.1	±5	-	±20	μΑ

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Symbol	Parameter	Conditions		-40	°C to +8	5 °C	-40 °C to	+125 °C	Unit
				Min	Typ[1]	Max	Min	Max	
l _{OZ}	OFF-state output current	$V_I = V_{IH}$ or V_{IL} ; $V_O = 5.5$ V or GND; $V_{CC} = 3.6$ V	[2]	-	0.1	±10	-	±20	μA
I _{OFF}	power-off leakage current	$V_{CC} = 0 \text{ V}; V_{I} \text{ or } V_{O} = 5.5 \text{ V}$		-	0.1	10	-	20	μA
I _{CC}	supply current	V_{CC} = 3.6 V; V_I = V_{CC} or GND; I_O = 0 A		-	0.1	10	-	40	μΑ
ΔI _{CC}	additional supply current	per input pin; V _{CC} = 1.65 V to 3.6 V; V _I = V _{CC} - 0.6 V; I _O = 0 A		-	5	500	-	5000	μA
Cı	input capacitance	V_{CC} = 0 V to 3.6 V; V_I = GND to V_{CC}		-	5.0	-	-	-	pF

^[1] All typical values are measured at V_{CC} = 3.3 V (unless stated otherwise) and T_{amb} = 25 °C.

11. Dynamic characteristics

Table 7. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V). For test circuit see Fig. 13.

Symbol	Parameter	Conditions	-40	°C to +8	5 °C	-40 °C to	+125 °C	Unit
			Min	Typ[1]	Max	Min	Max	
t _{pd}	propagation delay	SHCP to Q7S; see Fig. 7 [2]						
		V _{CC} = 1.2 V	-	17.5	-	-	-	ns
		V _{CC} = 1.65 V to 1.95 V	2.0	6.6	15.8	2.0	18.2	ns
		V _{CC} = 2.3 V to 2.7 V	1.5	4.2	8.1	1.5	9.3	ns
		V _{CC} = 2.7 V	1.5	4.7	7.6	1.5	8.7	ns
		V _{CC} = 3.0 V to 3.6 V	1.5	4.0	6.7	1.5	7.7	ns
		STCP to Qn; see Fig. 8 [2]						
		V _{CC} = 1.2 V	-	16.8	-	-	-	ns
		V _{CC} = 1.65 V to 1.95 V	2.0	5.8	15.8	2.0	18.2	ns
		V _{CC} = 2.3 V to 2.7 V	1.5	3.7	8.1	1.5	9.3	ns
		V _{CC} = 2.7 V	1.5	4.0	7.6	1.5	8.7	ns
		V _{CC} = 3.0 V to 3.6 V	1.2	3.3	6.7	1.2	7.7	ns
t _{PHL}	HIGH to LOW	MR to Q7S; see Fig. 11						
	propagation delay	V _{CC} = 1.2 V	-	17.3	-	-	-	ns
		V _{CC} = 1.65 V to 1.95 V	2.0	6.9	15.8	2.0	18.2	ns
		V _{CC} = 2.3 V to 2.7 V	1.5	4.3	8.1	1.5	9.3	ns
		V _{CC} = 2.7 V	1.5	4.5	7.6	1.5	8.7	ns
		V _{CC} = 3.0 V to 3.6 V	1.2	3.8	6.7	1.2	7.7	ns

^[2] For transceivers, the parameter I_{OZ} includes the input leaking current.

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Symbol	Parameter	Conditions		-40	°C to +85	S°C	-40 °C to	+125 °C	Unit
				Min	Typ[1]	Max	Min	Max	
t _{en}	enable time	OE to Qn; see Fig. 12	[3]						
		V _{CC} = 1.2 V		-	17.9	-	-	-	ns
		V _{CC} = 1.65 V to 1.95 V		2.0	6.4	14.1	2.0	16.2	ns
		V _{CC} = 2.3 V to 2.7 V		1.5	4.2	8.0	1.5	9.2	ns
		V _{CC} = 2.7 V		1.5	4.5	7.6	1.5	8.7	ns
		V _{CC} = 3.0 V to 3.6 V		1.2	3.8	6.7	1.2	7.7	ns
dis	disable time	OE to Qn; see Fig. 12	[4]						
		V _{CC} = 1.2 V		-	9.6	-	-	-	ns
		V _{CC} = 1.65 V to 1.95 V		2.0	4.9	9.8	2.0	11.2	ns
		V _{CC} = 2.3 V to 2.7 V		1.2	2.8	5.8	1.2	6.6	ns
		V _{CC} = 2.7 V		1.5	3.7	6.2	1.5	7.1	ns
		V _{CC} = 3.0 V to 3.6 V		1.2	3.5	5.7	1.2	6.5	ns
w p	pulse width	SHCP, STCP HIGH or LOW; see Fig. 7 and Fig. 8							
		V _{CC} = 1.65 V to 1.95 V		6.0	2.5	-	7.0	-	ns
		V _{CC} = 2.3 V to 2.7 V		5.0	2.0	-	5.5	-	ns
		V _{CC} = 2.7 V		4.5	1.5	-	5.0	-	ns
		V _{CC} = 3.0 V to 3.6 V		4.0	1.5	-	4.5	-	ns
		MR LOW; see Fig. 11							
		V _{CC} = 1.65 V to 1.95 V		5.0	2.0	-	5.5	-	ns
		V _{CC} = 2.3 V to 2.7 V		4.0	1.5	-	4.5	-	ns
		V _{CC} = 2.7 V		2.5	1.0	-	3.0	-	ns
		V _{CC} = 3.0 V to 3.6 V		2.5	1.0	-	3.0	-	ns
su	set-up time	DS to SHCP; see Fig. 9							
		V _{CC} = 1.65 V to 1.95 V		5.0	0.4	-	5.5	-	ns
		V _{CC} = 2.3 V to 2.7 V		4.0	0.1	-	4.5	-	ns
		V _{CC} = 2.7 V		2.0	0	-	2.5	-	ns
		V _{CC} = 3.0 V to 3.6 V		2.0	-0.1	-	2.5	-	ns
		MR to STCP; see Fig. 10							+
		V _{CC} = 1.65 V to 1.95 V		8.0	3.5	-	8.5	-	ns
		V _{CC} = 2.3 V to 2.7 V		5.0	2.1	-	5.5	-	ns
		V _{CC} = 2.7 V		4.0	1.8	-	4.5	-	ns
		V _{CC} = 3.0 V to 3.6 V		4.0	1.7	-	4.5	-	ns
		SHCP to STCP; see Fig. 8							
		V _{CC} = 1.65 V to 1.95 V		8.0	3.5	-	8.5	-	ns
		V _{CC} = 2.3 V to 2.7 V		5.0	2.1	-	5.5	-	ns
		V _{CC} = 2.7 V		4.0	1.8	-	4.5	-	ns
		V _{CC} = 3.0 V to 3.6 V		4.0	1.7	-	4.5	-	ns
า	hold time	DS to SHCP; see Fig. 9							+
•		V _{CC} = 1.65 V to 1.95 V		1.5	0.2	-	2.0	-	ns
		V _{CC} = 2.3 V to 2.7 V		1.5	0.1	-	2.0	_	ns
		V _{CC} = 2.7 V		1.5	-0.1	_	2.0	_	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		1.0	-0.2	_	1.5	_	ns

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Symbol	Parameter	Conditions		-40	°C to +85	5 °C	-40 °C to	+125 °C	Unit
				Min	Typ[1]	Max	Min	Max	
t _{rec}	recovery time	MR to SHCP; see Fig. 11							
		V _{CC} = 1.65 V to 1.95 V		5.0	-2.7	-	5.5	-	ns
		V _{CC} = 2.3 V to 2.7 V		4.0	-1.5	-	4.5	-	ns
		V _{CC} = 2.7 V		2.0	-1.0	-	2.5	-	ns
		V _{CC} = 3.0 V to 3.6 V		2.0	-1.0	-	2.5	-	ns
·IIIax	maximum frequency	SHCP or STCP; see Fig. 7 and Fig. 8							
		V _{CC} = 1.65 V to 1.95 V		80	130	-	70	-	MHz
		V _{CC} = 2.3 V to 2.7 V		100	140	-	90	-	MHz
		V _{CC} = 2.7 V		110	150	-	100	-	MHz
		V _{CC} = 3.0 V to 3.6 V		130	180	-	115	-	MHz
t _{sk(o)}	output skew time	V _{CC} = 3.0 V to 3.6 V	[5]	-	-	1.0	-	1.5	ns
C _{PD}	power dissipation	V _I = GND to V _{CC}	[6]						
	capacitance	V _{CC} = 1.65 V to 1.95 V		-	50	-	-	-	pF
		V _{CC} = 2.3 V to 2.7 V		-	45	-	-	-	pF
		V _{CC} = 3.0 V to 3.6 V		-	44	-	-	-	pF

- [1] Typical values are measured at T_{amb} = 25 °C and V_{CC} = 1.8 V, 2.5 V, 2.7 V, and 3.3 V respectively.
- [2] t_{pd} is the same as t_{PLH} and t_{PHL} .
- [3] t_{en} is the same as t_{PZH} and t_{PZL} .
- [4] t_{dis} is the same as t_{PHZ} and t_{PLZ} .
- [5] Skew between any two outputs of the same package switching in the same direction. This parameter is guaranteed by design.
- [6] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

$$P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \Sigma (C_L \times V_{CC}^2 \times f_o)$$
 where:

 f_i = input frequency in MHz;

 f_o = output frequency in MHz;

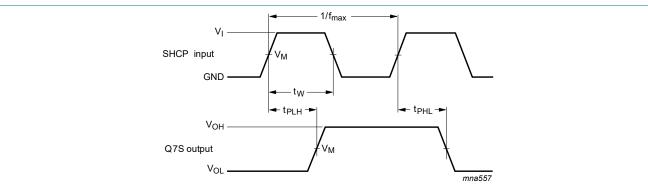
C_L = output load capacitance in pF;

V_{CC} = supply voltage in V;

N = number of inputs switching;

 $\Sigma(C_L \times V_{CC}^2 \times f_0) = \text{sum of outputs.}$

11.1. Waveforms and test circuit

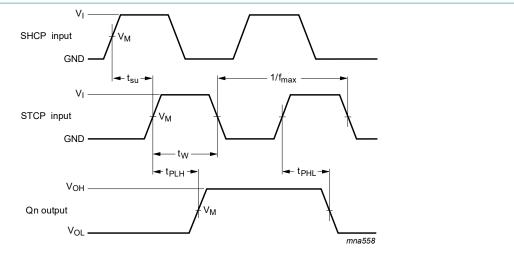


Measurement points are given in Table 8.

V_{OL} and V_{OH} are typical output voltage drops that occur with the output load.

Fig. 7. The shift clock (SHCP) to serial data output (Q7S) propagation delays, the shift clock pulse width and maximum shift clock frequency

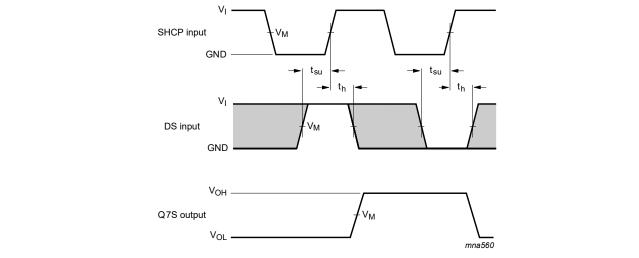
8-bit serial-in/serial-out or parallel-out shift register; 3-state



Measurement points are given in Table 8.

 V_{OL} and V_{OH} are typical output voltage drops that occur with the output load.

Fig. 8. The storage clock (STCP) to parallel data output (Qn) propagation delays, the storage clock pulse width and the shift clock to storage clock set-up time

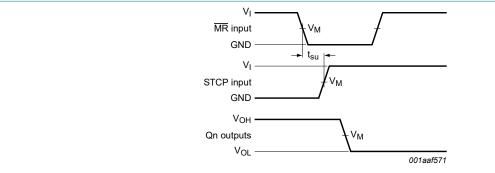


Measurement points are given in Table 8.

The shaded areas indicate when the input is permitted to change for predictable output performance.

 V_{OL} and V_{OH} are typical output voltage drops that occur with the output load.

Fig. 9. The data set-up and hold times for the serial data input (DS)

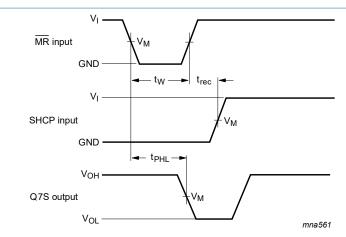


Measurement points are given in Table 8.

 V_{OL} and V_{OH} are typical output voltage drops that occur with the output load.

Fig. 10. The master reset (MR) to storage clock (STCP) set-up times

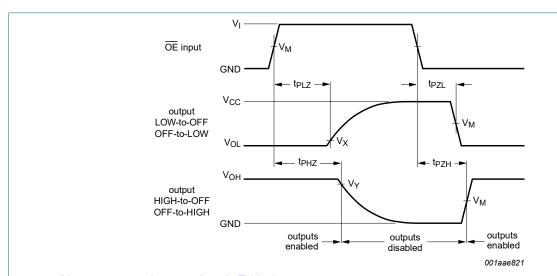
8-bit serial-in/serial-out or parallel-out shift register; 3-state



Measurement points are given in Table 8.

 V_{OL} and V_{OH} are typical output voltage drops that occur with the output load.

Fig. 11. The master reset (MR) pulse width, the master reset to serial data output (Q7S) propagation delays and the master reset to shift clock (SHCP) recovery time



Measurement points are given in <u>Table 8</u>.

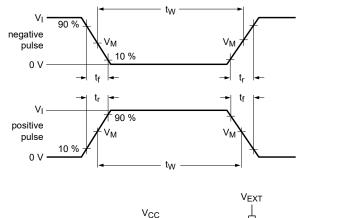
 V_{OL} and V_{OH} are typical output voltage drops that occur with the output load.

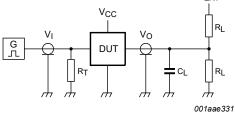
Fig. 12. 3-state enable and disable times

Table 8. Measurement points

Supply voltage	Input	Output	Output						
V _{CC}	V _M	V _M	V _X	V _Y					
V _{CC} < 2.7 V	0.5 × V _{CC}	0.5 × V _{CC}	V _{OL} + 0.15 V	V _{OH} - 0.15 V					
V _{CC} ≥ 2.7 V	1.5 V	1.5 V	V _{OL} + 0.3 V	V _{OH} - 0.3 V					

8-bit serial-in/serial-out or parallel-out shift register; 3-state





Test data is given in <u>Table 9</u>. Definitions for test circuit:

 R_L = Load resistance.

 C_L = Load capacitance including jig and probe capacitance.

 R_{T} = Termination resistance should be equal to output impedance Z_{o} of the pulse generator.

V_{EXT} = External voltage for measuring switching times.

Fig. 13. Test circuit for measuring switching times

Table 9. Test data

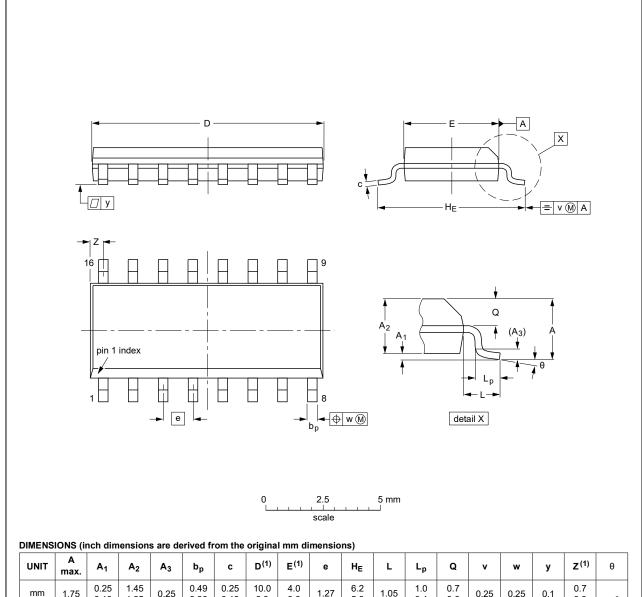
Supply voltage	Input		Load	LAI		V _{EXT}		
	V _I	t _r , t _f	CL	R _L	t _{PLH} , t _{PHL}	t_{PLZ}, t_{PZL}	t _{PHZ} , t _{PZH}	
1.2 V	V _{CC}	≤ 2 ns	30 pF	1 kΩ	open	2 × V _{CC}	GND	
1.65 V to 1.95 V	V _{CC}	≤ 2 ns	30 pF	1 kΩ	open	2 × V _{CC}	GND	
2.3 V to 2.7 V	V _{CC}	≤ 2 ns	30 pF	500 Ω	open	2 × V _{CC}	GND	
2.7 V	2.7 V	≤ 2.5 ns	50 pF	500 Ω	open	2 × V _{CC}	GND	
3.0 V to 3.6 V	2.7 V	≤ 2.5 ns	50 pF	500 Ω	open	2 × V _{CC}	GND	

8-bit serial-in/serial-out or parallel-out shift register; 3-state

12. Package outline



SOT109-1



	UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
	mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	10.0 9.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
i	inches	0.069	0.010 0.004	0.057 0.049	0.01		0.0100 0.0075	0.39 0.38	0.16 0.15	0.05	0.244 0.228	0.041	0.039 0.016	0.028 0.020	0.01	0.01	0.004	0.028 0.012	0°

Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

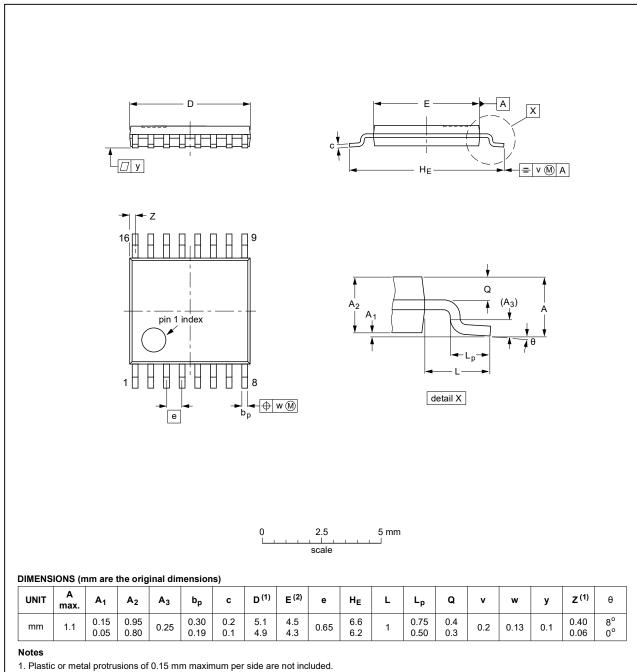
OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT109-1	076E07	MS-012				99-12-27 03-02-19	

Fig. 14. Package outline SOT109-1 (SO16)

8-bit serial-in/serial-out or parallel-out shift register; 3-state

TSSOP16: plastic thin shrink small outline package; 16 leads; body width 4.4 mm

SOT403-1



2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT403-1		MO-153				99-12-27 03-02-18	

Fig. 15. Package outline SOT403-1 (TSSOP16)

8-bit serial-in/serial-out or parallel-out shift register; 3-state

DHVQFN16: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body 2.5 x 3.5 x 0.85 mm SOT763-1

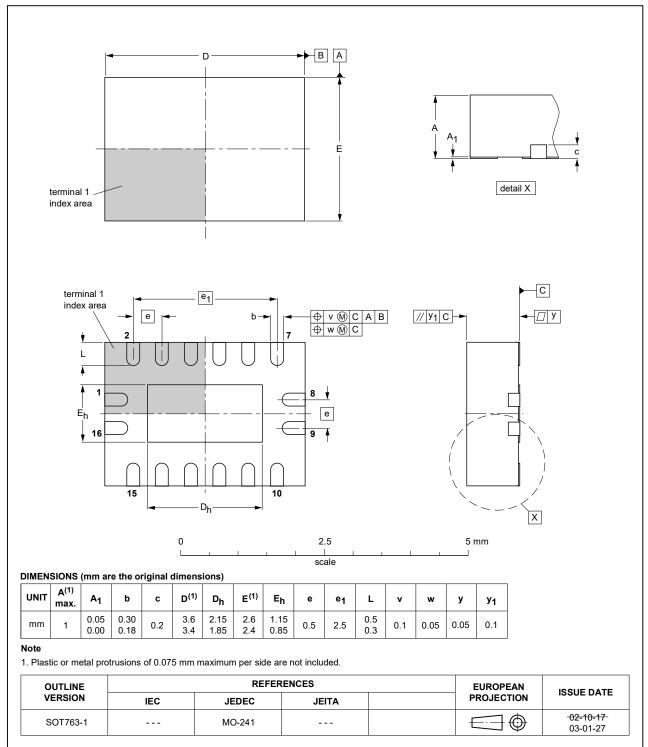


Fig. 16. Package outline SOT763-1 (DHVQFN16)

8-bit serial-in/serial-out or parallel-out shift register; 3-state

13. Abbreviations

Table 10. Abbreviations

Acronym	Description
CDM	Charged Device Model
CMOS	Complementary Metal Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MM	Machine Model
TTL	Transistor-Transistor Logic

14. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes		
74LVC595A v.3	20211119	Product data sheet	-	74LVC595A v.2		
Modifications:	Nexperia. • Legal texts ha • <u>Section 1</u> and	this data sheet has been redes ve been adapted to the new co <u>Section 2</u> updated. rating values for P _{tot} total powe	ompany name where	appropriate.		
74LVC595A v.2 20140620 Product data sheet - 74LVC5				74LVC595A v.1		
 Modifications: The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. Figure note for Fig. 6 added. 						
74LVC595A v.1	20070529	Product data sheet	-	-		

8-bit serial-in/serial-out or parallel-out shift register; 3-state

15. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition		
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.		
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.		
Product [short] data sheet	Production	This document contains the product specification.		

- Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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8-bit serial-in/serial-out or parallel-out shift register; 3-state

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